

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10596973	BAIDEN, GREG
Examiner	Art Unit	
Hanh Phan	2613	

SEARCHED

Class	Subclass	Date	Examiner
398	104, 105, 33, 177, 140, 135, 124, 118, 119, 123, 128, 130	11/06/2010	HP
367	134, 131, 133, 117, 910	11/06/2010	HP
UPDATE SEARCH		11/06/2010	HP

SEARCH NOTES

Search Notes	Date	Examiner
EAST SEARCH SEE ATTACHED PRINTOUT IN THE FILE	11/06/2010	HP
IEEE SEARCH	11/06/2010	HP
JPO SEARCH	11/06/2010	HP
PPGPUB TEXT SEARCH SEE INTERFERENCE SEARCH PRINTOUT	11/06/2010	HP

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
398	104, 105, 33, 177, 140, 135, 124, 118, 119, 123, 128, 130	11/06/2010	HP
367	134, 131, 133, 117, 910	11/06/2010	HP

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